

**Search Notes**

Application/Contr. IN .

09/971,080

Examiner

Michael T. Thier

Applicant(s)/Patent under  
Re examination

SHAH, HITESH

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
See	prior		
searches			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search. See attached EAST search.	7/14/2006	MTT
Spoke with Duc Nguyen.	7/14/2006	MTT